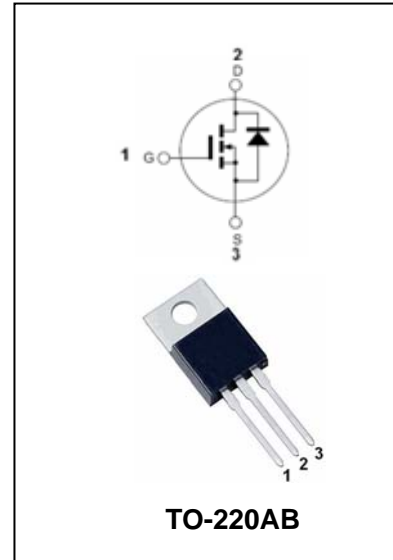


N-Channel Enhancement Mode Field Effect Transistor

BL5N50

FEATURES

- Low on-resistance.
- Low leakage current.
- High speed switching.
- Low gate charge.
- Avalanche ratings.



MAXIMUM RATING operating temperature range applies unless otherwise specified

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage	500	V
V_{GS}	Gate -Source Voltage	± 30	V
I_D	Drain Current	5	A
$I_{D(pulse)}$	Drain Current(pulsed) Note1	20	A
I_{DR}	Body-drain diode reverse drain current	5	A
$I_{DR(pulse)}$	Body-drain diode reverse drain peak current(pulsed) Note1	20	A
I_{AP}	Avalanche current Note3	5	A
Pch	Channel dissipation Note2	30	W
$R_{\theta JA}$	Channel to case Thermal Impedance	4.17	$^{\circ}C/W$
Tch	Channel temperature	150	$^{\circ}C$
T_{stg}	StorageTemperature Range	-55 to +150	$^{\circ}C$

Note: 1. $PW \leq 10\mu s$, duty cycle $\leq 1\%$

2. Value at $T_c = 25^{\circ}C$

3. $T_{ch} \leq 150^{\circ}C$

N-Channel Enhancement Mode Field Effect Transistor

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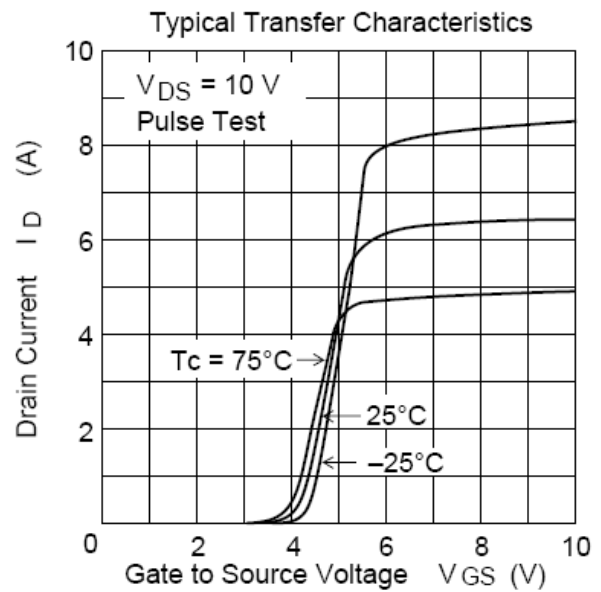
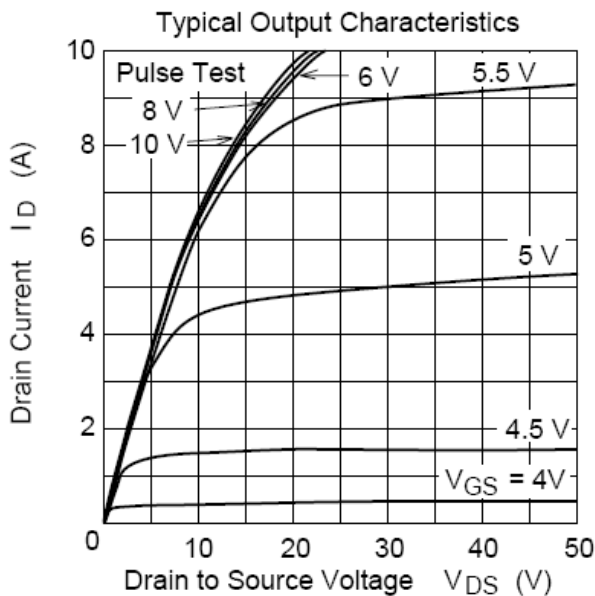
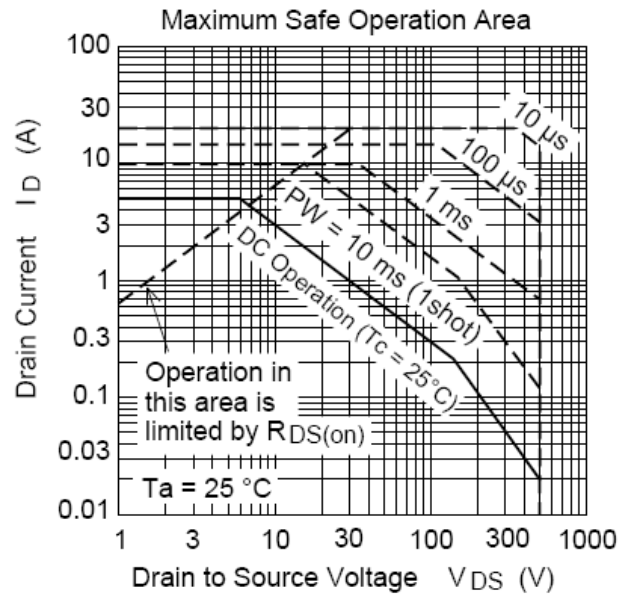
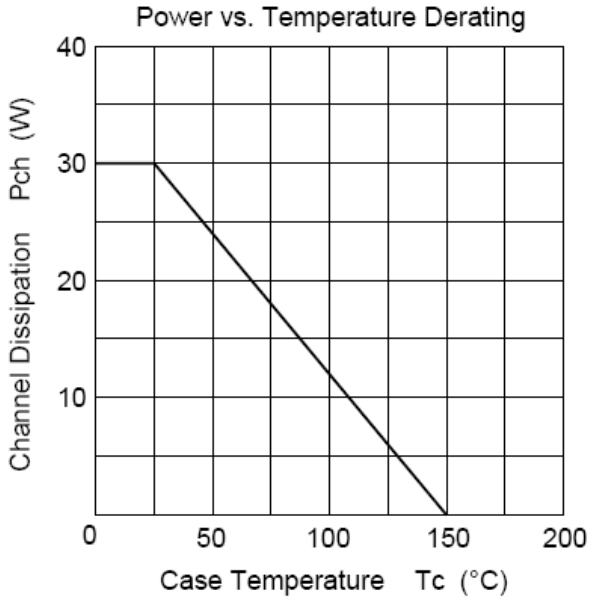
ELECTRICAL CHARACTERISTICS @ Ta=25°C unless otherwise specified

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=10mA$	500	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=500V, V_{GS}=0V$	-	-	1	μA
Gate-body Leakage	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 30V$	-	-	± 0.1	μA
Gate to source cutoff voltage	$V_{GS(off)}$	$V_{DS}=10V, I_D=1mA$	3	-	4	V
Static drain-Source On-resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=2.5A$	-	1.1	1.5	Ω
Forward Transconductance	g_{fs}	$V_{DS}=10V, I_D=2.5A$	3	4.5	-	S
Input Capacitance	C_{ISS}	$V_{DS}=25V, V_{GS}=0V$ $f=1.0MHz$	-	580	-	pF
Output Capacitance	C_{OSS}		-	70	-	pF
Reverse Transfer Capacitance	C_{RSS}		-	13	-	pF
Turn-On Delay Time	$t_{D(ON)}$	$I_D=2.5A, R_G=10\Omega$ $R_L=100\Omega, V_{GS}=10V$	-	20	-	ns
Rise Time	t_R		-	15	-	ns
Turn-Off Delay Time	$t_{D(OFF)}$		-	65	-	ns
Fall Time	t_F		-	15	-	ns
Total Gate Charge	Q_g	$V_{DD}=400V, V_{GS}=10V$ $I_D=5A$	-	15	-	nC
Gate-source Charge	Q_{gs}		-	3	-	nC
Gate-drain Charge	Q_{gd}		-	8	-	nC
Reverse Recovery Time	T_{rr}	$I_F=5A, V_{GS}=0V$ $dI_F/dt=100A/\mu s,$	-	400	-	ns
Reverse Recovery Charge	Q_{rr}		-	1.5	-	μC
Body-drain diode forward voltage	V_{DF}	$I_F=5A, V_{GS}=0V$		0.85	1.3	V

N-Channel Enhancement Mode Field Effect Transistor

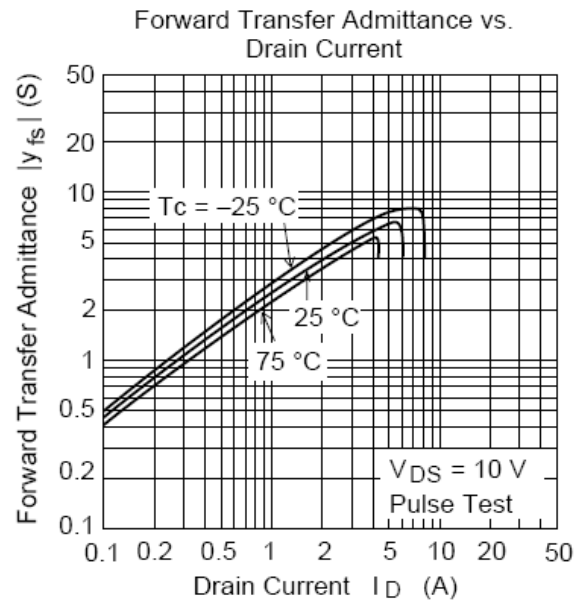
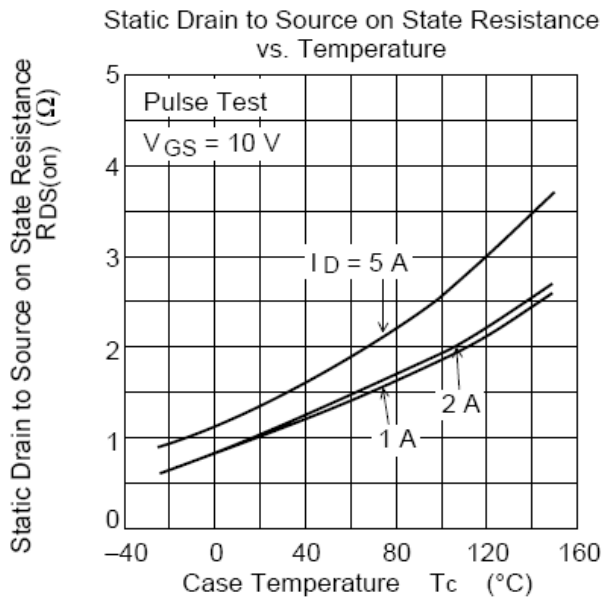
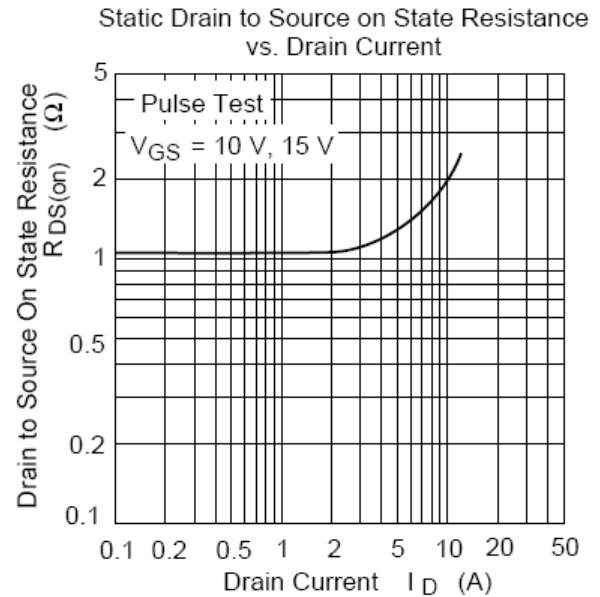
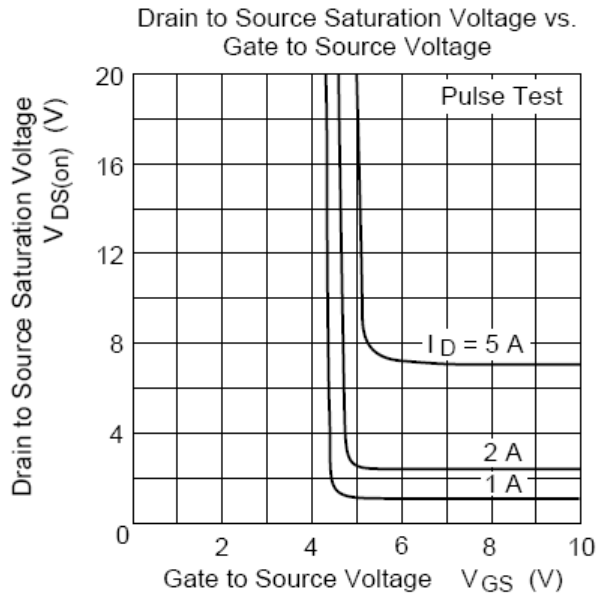
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TYPICAL CHARACTERISTICS @ $T_a=25^\circ\text{C}$ unless otherwise specified



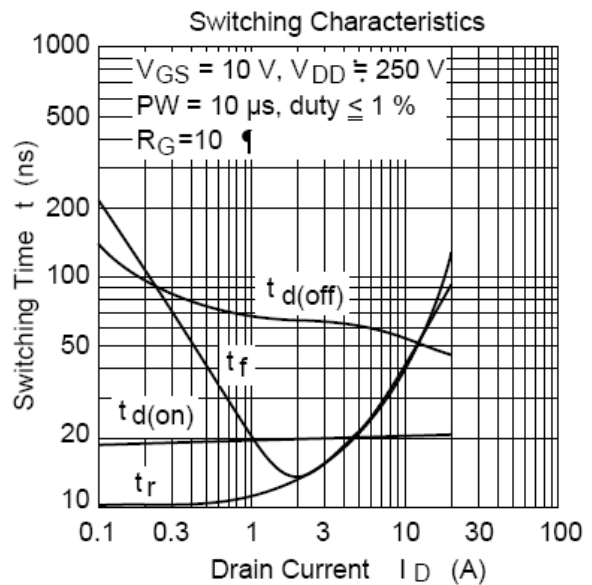
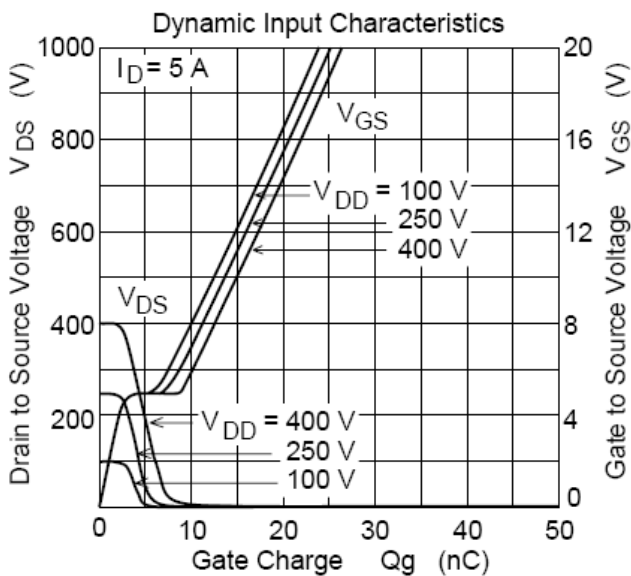
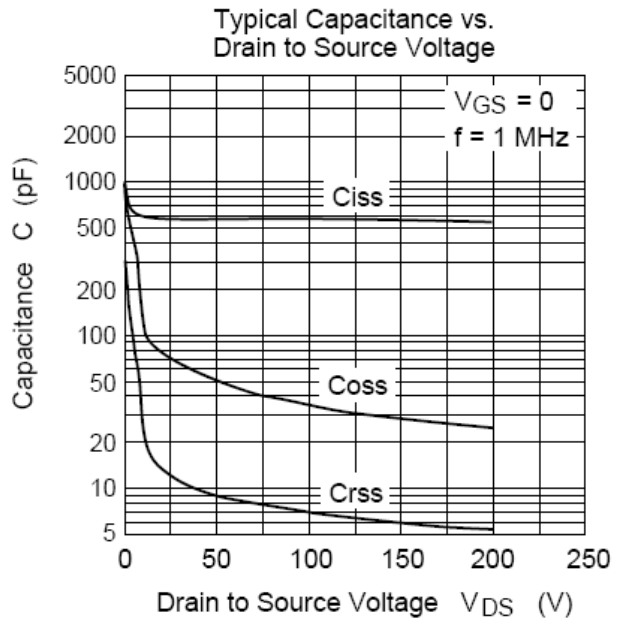
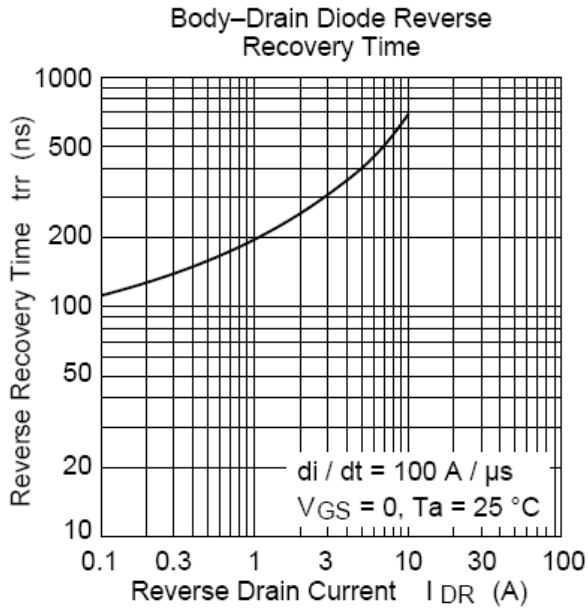
N-Channel Enhancement Mode Field Effect Transistor

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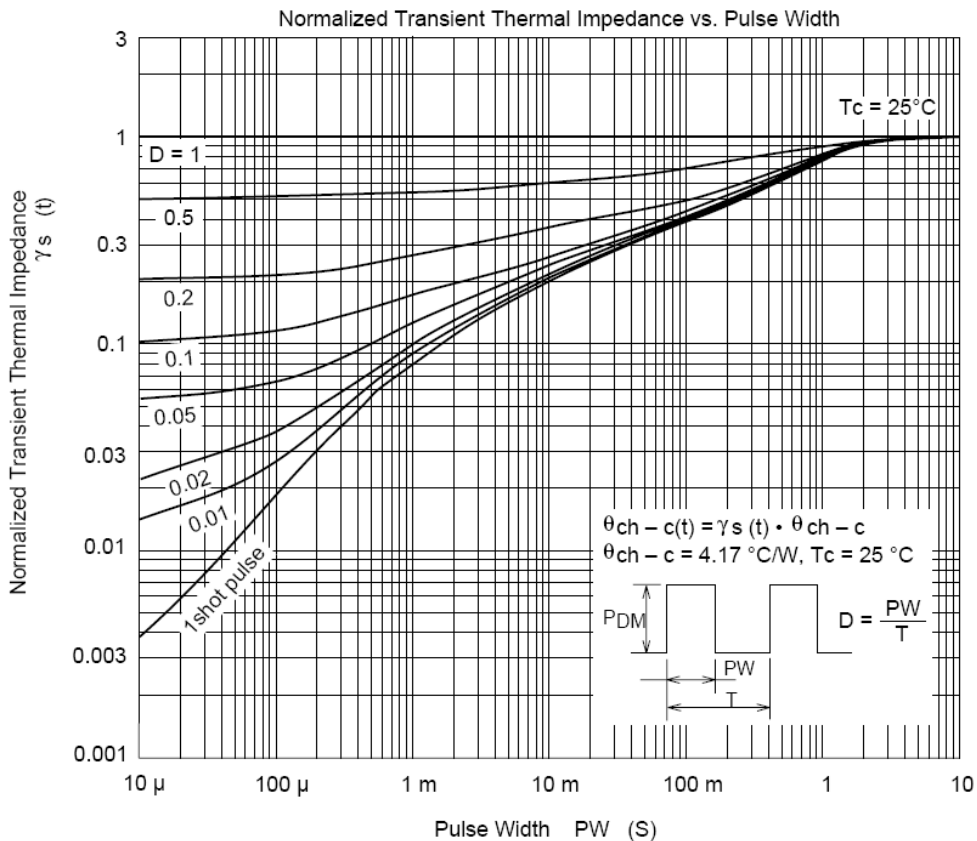
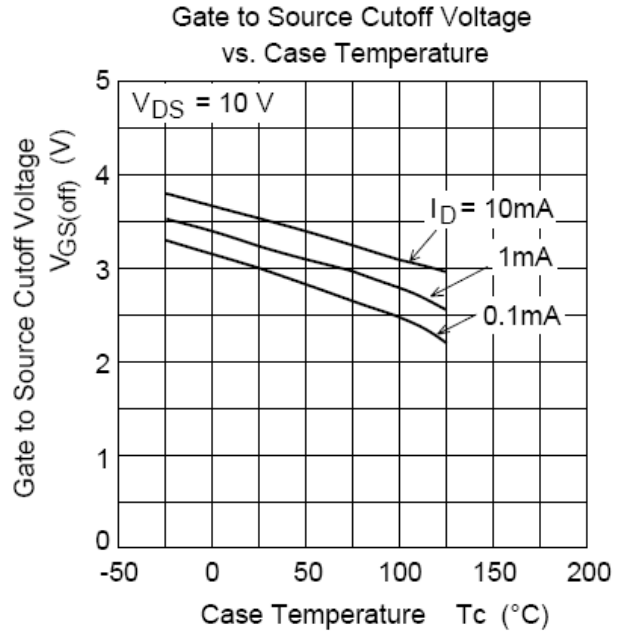
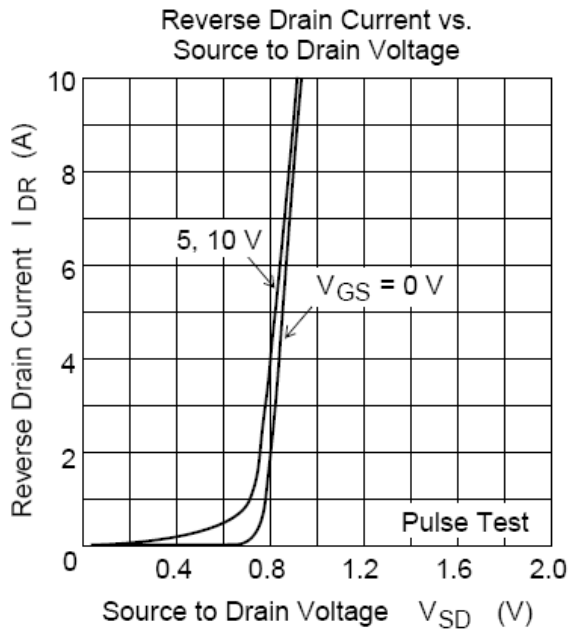
N-Channel Enhancement Mode Field Effect Transistor

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N-Channel Enhancement Mode Field Effect Transistor

BL5N50



N-Channel Enhancement Mode Field Effect Transistor

BL5N50

PACKAGE OUTLINE

Plastic surface mounted package

TO-220AB

